

Search Notes

Application/Control No.

10/646,058

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner
330	149	3/11/2005	PN
//	284		
455	114		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
330	149	3/11/2005	PN
//	284		
455	114		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR